

General Description

The ZM029P03D combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

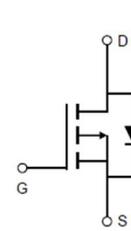
Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

Application

- Synchronous Rectification for AC-DC/DC-DC converter
- Oring switches
- BLDC Motor driver

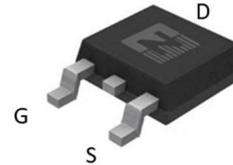
Product Summary



$V_{DS} = -30V$

$R_{DS(ON)} = 2.9m\Omega$

$I_D = -100A$



TO-252

Ordering Information:

| | |
|---------------------------|-----------|
| Part NO. | ZM029P03D |
| Marking | ZM029P03 |
| Packing Information | REEL TAPE |
| Basic ordering unit (pcs) | 2500 |

Absolute Maximum Ratings ($T_c = 25^\circ C$)

| Parameter | Symbol | Rating | Unit |
|---------------------------------------|------------------------|------------|------------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current | $I_{D@TC=25^\circ C}$ | -100 | A |
| | $I_{D@TC=75^\circ C}$ | -76 | A |
| | $I_{D@TC=100^\circ C}$ | -63 | A |
| Pulsed Drain Current ^① | I_{DM} | -300 | A |
| Total Power Dissipation | $P_D@TC=25^\circ C$ | 90 | W |
| Total Power Dissipation | $P_D@TA=25^\circ C$ | 2 | W |
| Operating Junction Temperature | T_J | -55 to 150 | $^\circ C$ |
| Storage Temperature | T_{STG} | -55 to 150 | $^\circ C$ |
| Single Pulse Avalanche Energy@L=0.1mH | E_{AS} | 800 | mJ |

•Thermal resistance

| Parameter | Symbol | Min. | Typ. | Max. | Unit |
|---|------------|------|------|------|---------------|
| Thermal resistance, junction - case | R_{thJC} | - | - | 1.4 | $^{\circ}C/W$ |
| Thermal resistance, junction - ambient | R_{thJA} | - | - | 62.5 | $^{\circ}C/W$ |
| Soldering temperature, wave soldering for 10s | T_{sold} | - | - | 265 | $^{\circ}C$ |

•Electronic Characteristics

| Parameter | Symbol | Condition | Min. | Typ | Max. | Unit |
|-----------------------------------|--------------|------------------------------------|------|-----|-----------|------------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS} = 0V, I_D = -250\mu A$ | -30 | | | V |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS} = V_{DS}, I_D = -250\mu A$ | -1.2 | | -2.5 | V |
| Drain-Source Leakage Current | I_{DSS} | $V_{DS} = -30V, V_{GS} = 0V$ | | | 1.0 | μA |
| Gate- Source Leakage Current | I_{GSS} | $V_{GS} = \pm 20V, V_{DS} = 0V$ | | | ± 100 | nA |
| Static Drain-source On Resistance | $R_{DS(ON)}$ | $V_{GS} = -10V, I_D = -24A$ | | 2.9 | 3.8 | m Ω |
| | | $V_{GS} = -4.5V, I_D = -12A$ | | 3.6 | 5.2 | m Ω |
| Forward Transconductance | g_{FS} | $V_{DS} = -25V, I_D = -10A$ | | 20 | | s |
| Source-drain voltage | V_{SD} | $I_S = -24A$ | | | 1.28 | V |

•Electronic Characteristics

| Parameter | Symbol | Condition | Min. | Typ | Max. | Unit |
|------------------------------|-----------|-------------------------------|------|------|------|------|
| Input capacitance | C_{iss} | $V_{DS} = -25V$ $f = 1MHz$ | - | 6950 | - | pF |
| Output capacitance | C_{oss} | | - | 517 | - | |
| Reverse transfer capacitance | C_{rss} | | - | 204 | - | |

•Gate Charge characteristics($T_a = 25^{\circ}C$)

| Parameter | Symbol | Condition | Min. | Typ | Max. | Unit |
|----------------------|----------|-----------------|------|-----|------|------|
| Total gate charge | Q_g | $V_{DD} = -15V$ | - | 130 | - | nC |
| Gate - Source charge | Q_{gs} | $I_D = -24A$ | - | 31 | - | |
| Gate - Drain charge | Q_{gd} | $V_{GS} = -10V$ | - | 15 | - | |

Note: ① Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$;

Fig.1 Gate-Charge Characteristics

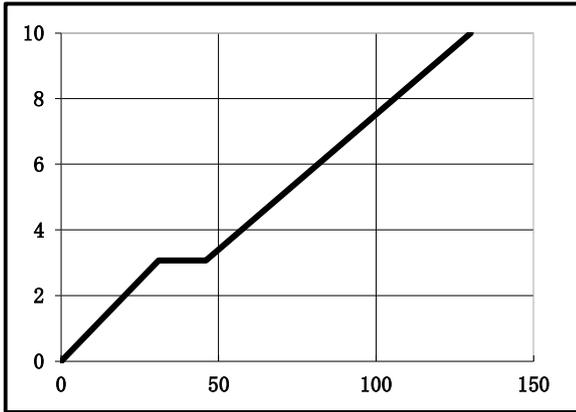


Fig.2 Capacitance Characteristics

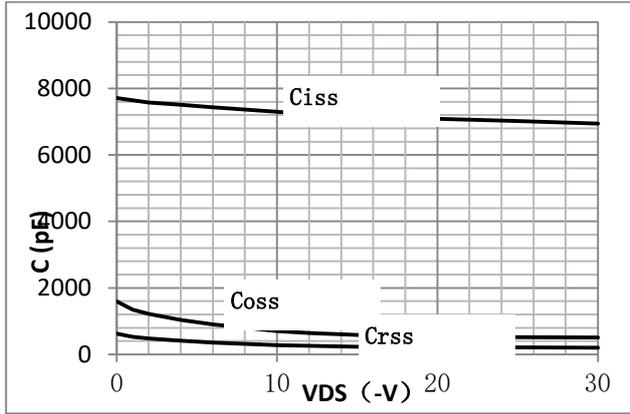


Fig.3 Power Dissipation

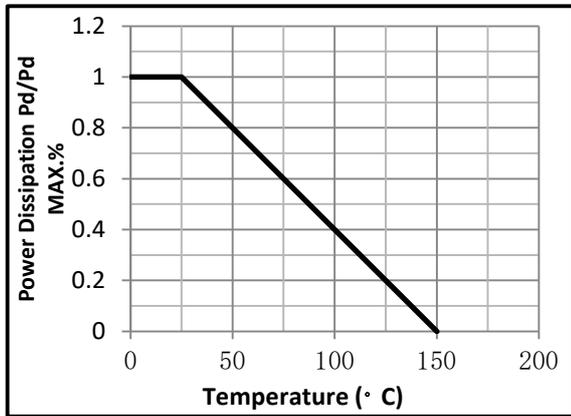


Fig.4 Typical output Characteristics

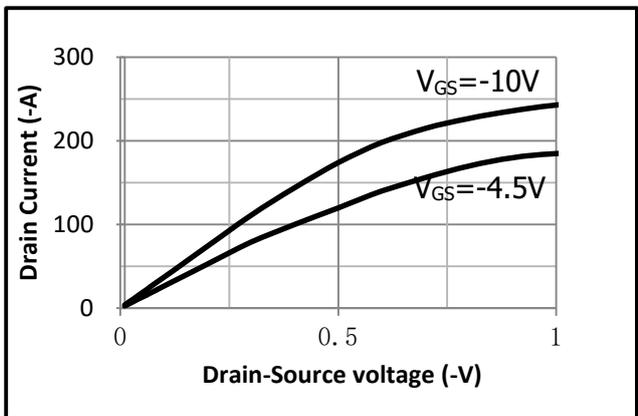


Fig.5 Threshold Voltage V.S Junction Temperature

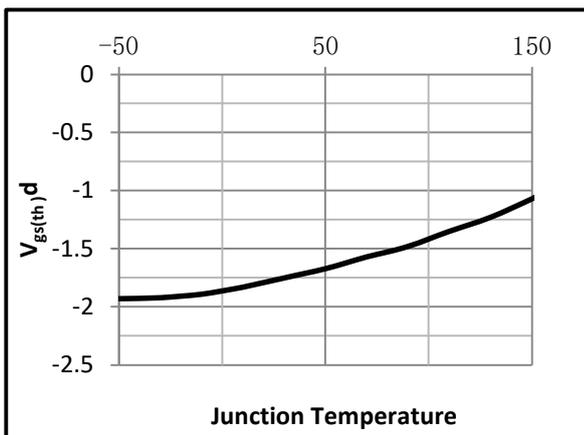


Fig.6 Resistance V.S Drain Current

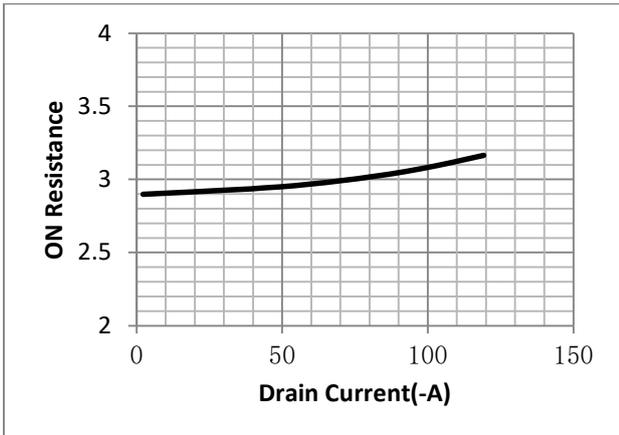


Fig.7 On-Resistance VS Gate Source Voltage

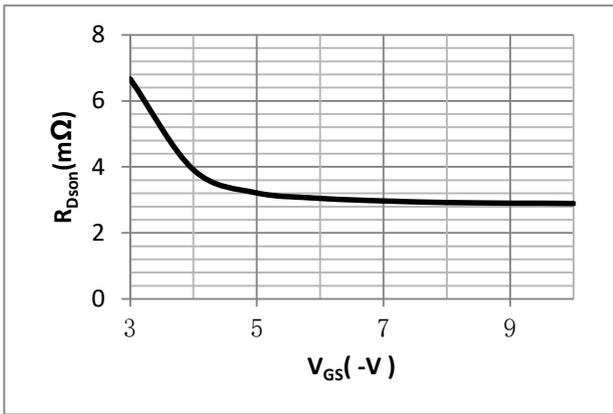


Fig.8 On-Resistance V.S Junction Temperature

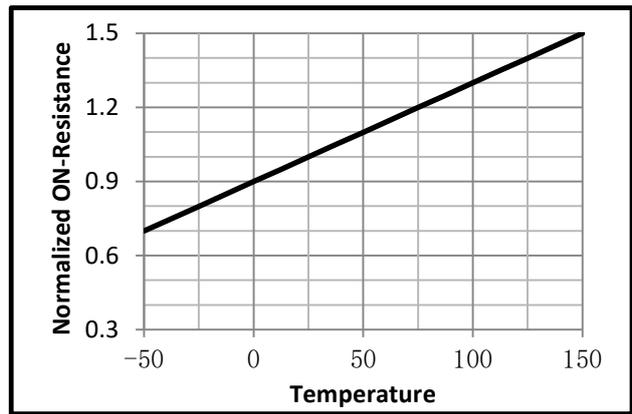


Fig.9 Gate Charge Time Measurement Circuit

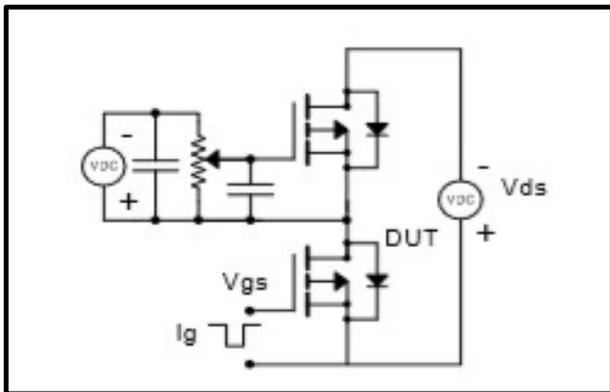


Fig.10 Gate Charge Waveform

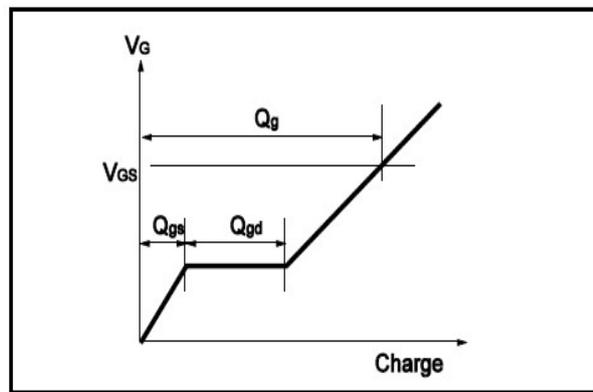


Fig.11 Switching Time Measurement Circuit

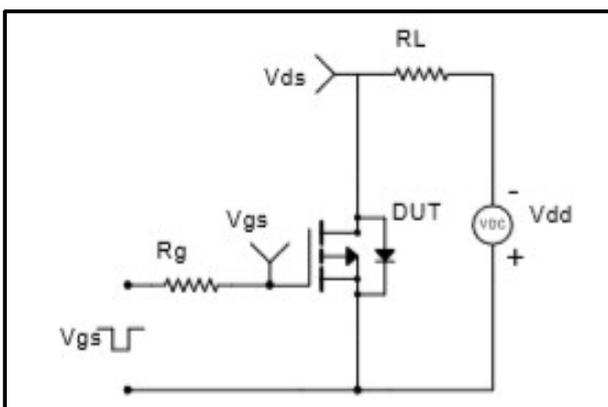
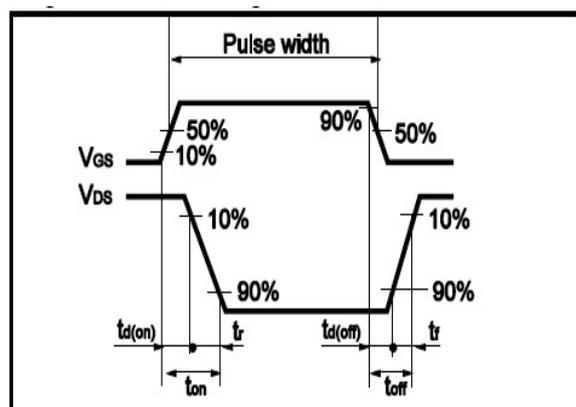


Fig.12 Switching Time Waveform





•Dimensions(TO-252)

Unit: mm

| SYMBOL | min | max | SYMBOL | min | max |
|--------|------|-------|--------|------|------|
| A | 2.10 | 2.50 | B | 0.85 | 1.25 |
| b | 0.50 | 0.80 | b1 | 0.50 | 0.90 |
| b2 | 0.45 | 0.70 | C | 0.45 | 0.70 |
| D | 6.30 | 6.75 | D1 | 5.10 | 5.50 |
| E | 5.30 | 6.30 | e1 | 2.25 | 2.35 |
| L1 | 9.20 | 10.60 | e2 | 4.45 | 4.75 |
| L2 | 0.90 | 1.75 | L3 | 0.60 | 1.10 |
| K | 0.00 | 0.23 | | | |

